Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/878,707	RYAN ET AL.	
Examiner	Art Unit	
Scott L. Jarrett	3623	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
East - EP, JP, US see attached search history	6/11/2007	SJ	
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